

MOSFET - Power, Single P-Channel

-40 V, 9.5 mΩ, -64 A

NVTFS9D6P04M8L

Features

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- NVTFWS9D6P04M8L Wettable Flanks Product
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	-40	V
Gate-to-Source Voltage	Э		V_{GS}	±20	V
Continuous Drain Current R _{B.IC}		T _C = 25°C	I _D	-64	Α
(Notes 1, 2, 4)	Steady	T _C = 100°C		-46	
Power Dissipation	State	T _C = 25°C	P_{D}	75	W
R _{θJC} (Notes 1, 2)		T _C = 100°C		38	
Continuous Drain		T _A = 25°C	I _D	-13	Α
Current R _{θJA} (Notes 1, 3, 4)	Steady	T _A = 100°C		-9	
Power Dissipation	State	T _A = 25°C	P_{D}	3.2	W
R _{θJA} (Notes 1, 3)		T _A = 100°C		1.6	
Pulsed Drain Current	$T_A = 25^\circ$	°C, t _p = 10 μs	I _{DM}	311	Α
Operating Junction and Range	Operating Junction and Storage Temperature Range			-55 to +175	°C
Source Current (Body Diode)			I _S	-62	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = -8.5 A)			E _{AS}	220	mJ
Lead Temperature for S (1/8" from case for 10 s		urposes	TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

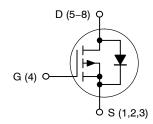
THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Drain) (Notes 1, 2, 4)	$R_{\theta JC}$	2	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	47	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- Assumes heat-sink sufficiently large to maintain constant case temperature independent of device power.
- 3. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
-40 V	9.5 m Ω @ –10 V	-64 A
_40 V	13.8 mΩ @ -4.5 V	0.7.

P-Channel MOSFET



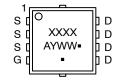


WDFN8 3.3x3.3, 0.65P CASE 511AB



WDFNW8 3.3x3.3, 0.65P (Full-Cut μ8FL WF) CASE 515AN

MARKING DIAGRAM



XXXX = Specific Device Code A = Assembly Location

Y = Year WW = Work Week • Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

See detailed ordering, marking and shipping information on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Test Cond	ition	Min	Тур	Max	Unit
OFF CHARACTERISTICS			<u>, </u>				
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D =	-250 μΑ	-40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				21		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{2.2} = 0.V T _J = 25°C				-1.0	μΑ
		$V_{GS} = 0 \text{ V},$ $V_{DS} = -40 \text{ V}$	T _J = 125°C			-1000	1
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)	1		L				1
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _D =	= –580 μΑ	-1.0		-2.4	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-5		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = -10 V, I _I	_O = -20 A		7.5	9.5	mΩ
		$V_{GS} = -4.5 \text{ V}, I_D = -10 \text{ A}$			10.7	13.8	1
Forward Transconductance	9FS	$V_{DS} = -1.5 \text{ V}, I_D = -15 \text{ A}$			46		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = -20 \text{ V}$			2312		pF
Output Capacitance	C _{oss}				923		7
Reverse Transfer Capacitance	C _{rss}				31		1
Total Gate Charge	Q _{G(TOT)}	V _{DS} = −20 V,	$V_{GS} = -4.5 \text{ V}$		16.2		nC
		I _D = -20 A	V _{GS} = -10 V		34.6		1
Threshold Gate Charge	Q _{G(TH)}		•		3.8		nC
Gate-to-Source Charge	Q_{GS}	$V_{GS} = -10 \text{ V}, V_{\Gamma}$	ns = -20 V,		6.9		1
Gate-to-Drain Charge	Q_{GD}	$V_{GS} = -10 \text{ V}, V_{D}$ $I_{D} = -20$	ĎÅ		4.1		1
Plateau Voltage	V_{GP}		ŀ		2.9		V
SWITCHING CHARACTERISTICS, VG	is = -4.5 V (Note	6)	•			•	•
Turn-On Delay Time	t _{d(on)}				12.6		ns
Rise Time	t _r	$V_{GS} = -4.5 \text{ V}, V_{D}$	ns = -20 V,		91.5		1
Turn-Off Delay Time	t _{d(off)}	$I_D = -20 \text{A}, R_C$	$_{i}$ = 2.5 Ω		74.6		1
Fall Time	t _f		ŀ		49.3		1
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	T _J = 25°C		-0.86	-1.25	V
		$I_S = -20 \text{ A}$	T _J = 125°C		-0.74		1
Reverse Recovery Time	t _{RR}				38.8		ns
Charge Time	ta	$V_{GS} = 0 \text{ V, } dI_S/dt$	= 100 A/us.		18.4		1
Discharge Time	t _b	$I_{S} = -20 \text{ A}$			20.4		1
Reverse Recovery Charge	Q _{RR}		ļ		19.7		nC

^{5.} Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

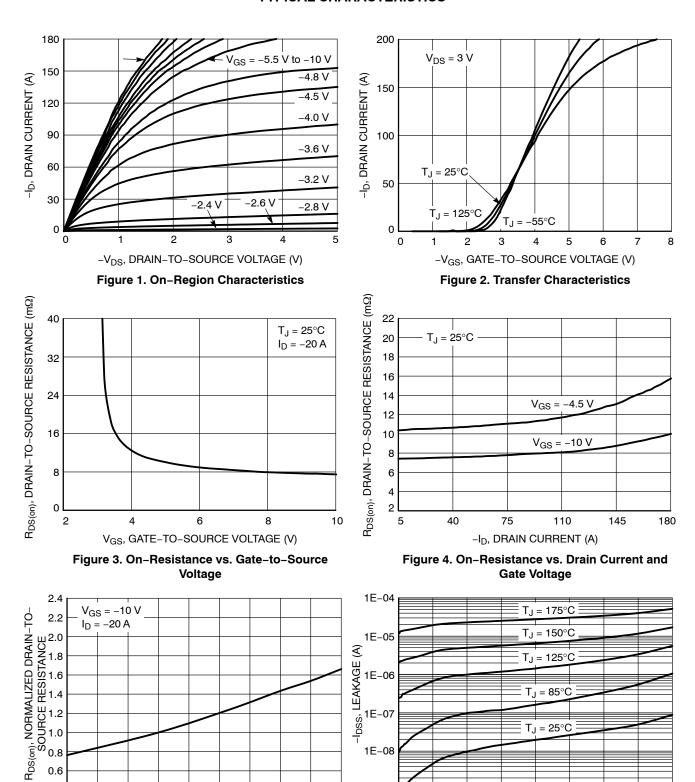


Figure 5. On–Resistance Variation with Temperature

T_J, JUNCTION TEMPERATURE (°C)

75

100

150

50

0.4

-50 -25

0

Figure 6. Drain-to-Source Leakage Current vs. Voltage

20

-V_{DS}, DRAIN-TO-SOURCE VOLTAGE (V)

25

15

35

40

30

175

1E-09

0

5

TYPICAL CHARACTERISTICS

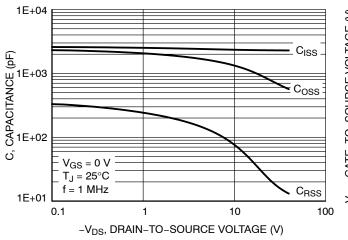


Figure 7. Capacitance Variation

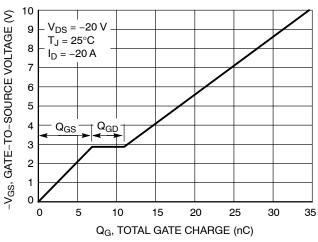


Figure 8. Gate-to-Source vs. Total Charge

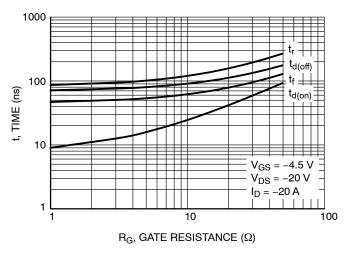


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

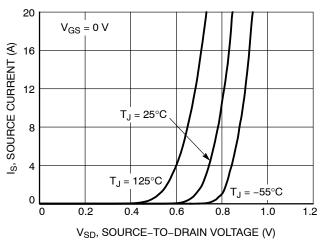


Figure 10. Diode Forward Voltage vs. Current

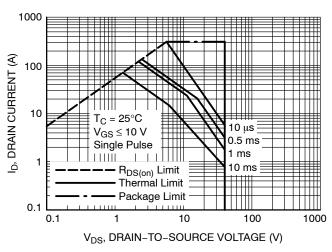


Figure 11. Maximum Rated Forward Biased Safe Operating Area

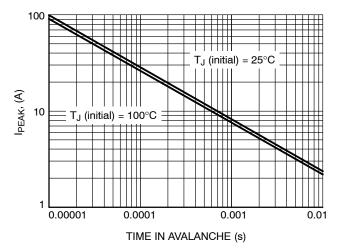


Figure 12. I_{PEAK} vs. Time in Avalanche

TYPICAL CHARACTERISTICS

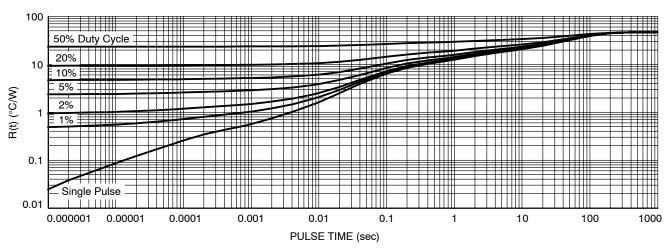


Figure 13. Thermal Characteristics

DEVICE ORDERING INFORMATION

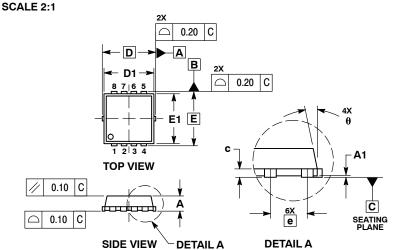
Device	Marking	Package	Shipping [†]
NVTFS9D6P04M8LTAG	9D6M	WDFN8 3.3x3.3, 0.65P (Pb-Free)	1500 / Tape & Reel
NVTFWS9D6P04M8LTAG	9D6W	WDFNW8 3.3x3.3, 0.65P (Full-Cut μ8FL WF) (Pb-Free, Wettable Flanks)	1500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

DATE 23 APR 2012



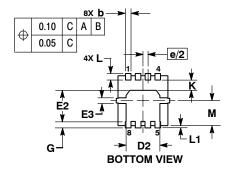
NOTES:

0.75 0.57

0.47

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
 PROTRUSIONS OR GATE BURRS.

	MI	LLIMETE	RS		INCHES	
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
b	0.23	0.30	0.40	0.009	0.012	0.016
С	0.15	0.20	0.25	0.006	0.008	0.010
D		3.30 BSC		0	.130 BSC)
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
E		3.30 BSC		0	.130 BSC)
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	0.23	0.30	0.40	0.009	0.012	0.016
е	0.65 BSC			(0.026 BS0	2
G	0.30	0.41	0.51	0.012	0.016	0.020
K	0.65	0.80	0.95	0.026	0.032	0.037
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
М	1.40	1.50	1.60	0.055	0.059	0.063
θ	0 °		12 °	0 °		12 °



GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code = Assembly Location

= Year WW = Work Week = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking.

Pb-Free indicator, "G" or microdot " ■", may or may not be present.

_[0.66 PACKAGE OUTLINE 3.60

SOLDERING FOOTPRINT*

DIMENSION: MILLIMETERS

2.30

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

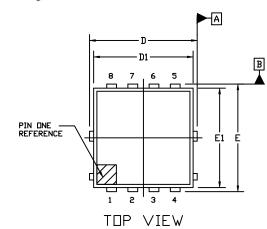
3.46

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WDFNW8 3.3x3.3, 0.65P (Full-Cut μ8FL WF) CASE 515AN ISSUE O

DATE 25 AUG 2020

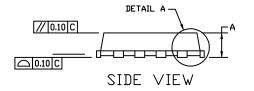


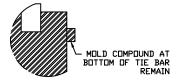
NOTES:

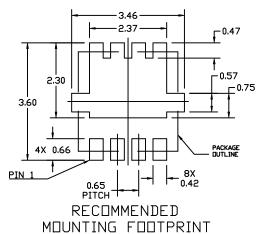
- 1. DIMENSIONING AND TOLERANCING PER.ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- DIMENSION D1 AND E1 D0 NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

	Α
	A1
PLATED AREA	b
/ /	c
, (/ \ \ \ \ \ \ \ \ \ \	D
	D1
, † – † †	D2
, <u>c</u>	Ε
DETAIL A SEATING	E1
PLANE	E2
	E3
	e
	G

	MILLIMETERS				
DIM	MIN.	NDM.	MAX.		
Α	0.70	0.75	0.80		
A1	0.00		0.05		
b	0.23	0.30	0.40		
U	0.15	0.20	0.25		
D	3.05	3.30	3.55		
D1	2.95	3.05	3.15		
D2	1.98	2.11	2.24		
Ε	3.05	3.30	3.55		
E1	2.95	3.05	3.15		
E2	1.47	1.60	1.73		
E3	0.23	0.30	0.40		
e		0.65 BSC			
G	0.30	0.41	0.51		
K	0.65	0.80	0.95		
L	0.30	0.43	0.59		
L1	0.06	0.13	0.20		
М	1.40	1.50	1.60		







* For additional information on our Pb-Free strategy and soldering details, please download the DN Semiconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

GENERIC MARKING DIAGRAM*

XXXX AYWW• XXXX = Specific Device Code

A = Assembly Location

Y = Year

WW = Work Week

= Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

(Note: Microdot may be in either location)

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DESCRIPTION:	WDFNW8 3.3x3.3, 0.65P (F	WDFNW8 3.3x3.3, 0.65P (Full-Cut μ8FL WF)		

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